



#### GENERAL DESCRIPTION

The Harris ICM7209 is a versatile CMOS clock generator capable of driving a number of 5 volt systems with a variety of input requirements. When used to drive up to 5 TTL gates, the typical rise and fail times are 10ns.

The ICM7209 consists of an oscillator, a buffered output equal to the oscillator frequency and a second buffered output having an output frequency one-eighth that of the oscillator. The guaranteed maximum oscillator frequency is 10MHz. Connecting the DISABLE terminal to the negative supply forces the  $\div$ 8 output into the '0' state and the OUT1 into the '1' state.

## ORDERING INFORMATION

Part Number	Temperature Range	Package		
ICM7209IPA	-20°C to +85°C	8 pin PLASTIC		

# ICM7209

### FEATURES

- High Frequency Operation --- 10MHz Guaranteed
- Requires Only A Quartz Crystal and Two Capacitors
- Bipolar, CMOS Compatibility
- High Output Drive Capability  $5 \times TTL$  Fanout With 10ns Rise and Fall Times
- Low Power --- 50mW at 10MHz
- Choice of Two Output Frequencies --- Osc., and Osc. ÷ 8 Frequencies
- Disable Control for Both Outputs
- Wide Industrial Temperature Range 20°C to +85°C



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# ICM7209

# ABSOLUTE MAXIMUM RATINGS

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 $\label{eq:supply voltage} \begin{array}{c} 6V\\ Output \mbox{ Voltages } \\ 1nput \mbox{ Voltages } \\ V_{SS} = 0.3V \mbox{ to } V_{DD} + 0.3V \\ 0.3V \mbox{ to } V_{DD} + 0.3V \\ 1nput \mbox{ Voltages } \\ 1nput \mb$ 

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Power Dissipation (25°C) 300mW
Storage Temperature55°C to +125°C
Operating Temperature Range 20°C to +85°C
Lead Temperature (Soldering, 10sec)

NOTE: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions above those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended penods may affect device reliability.

# **ELECTRICAL CHARACTERISTICS**

 $(V_{DD} - V_{SS} = 5V$ , test circuit,  $f_{osc} = 10$ MHz,  $T_A = 25^{\circ}$ C unless otherwise specified.)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
ססי	Supply Current	Note 1 No Load		11	20	mA
Co	Disable Input Capacitance			5		pF
lilk	Disable Input Leakage	Either '1' or '0' state			±10	μA
VOL	Output Low State	Either OUT 1 or OUT $\div 8$ simulated 5 × TTL loads			0.4	v
VOH	Output High State	Either OUT 1 or OUT $\div 8$ simulated 5 × TTL loads	4.0	4.9		
ţĦ	Output Rise Time (Note 3)	Either OUT 1 or OUT $\div 8$ simulated 5 × TTL loads		10		ns
ţ	Output Fall Time (Note 3)	Either OUT 1 or OUT - 8 simulated 5 × TTL loads		10		
fosc	Minimum OSC Frequency for -8 Output	Note 2	2			MHz
	Output - 8 duty cycle	Any operating frequency Low state : High state		7:9		
GM	Oscillator Transconductance		80	200		μS

NOTES: 1. The power dissipation is a function of the oscillator frequency (1st ORDER EFFECT see curve) but is also effected to a small extent by the oscillator tank components.

2. The -8 circuitry uses a dynamic scheme. As with any dynamic system, information or data is stored on very small nodal capacitances instead of latches (static systems) and there is a lower cutoff frequency of operation. Dynamic dividers are used in the ICM7209 to significantly improve high frequency performance and to decrease power consumption.

3 Rise and fall times are defined between the output levels of 0.5 and 2.4 volts.



Figure 3: Test Circuit

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## **TYPICAL PERFORMANCE CHARACTERISTICS** $(V_{0D} - V_{SS} = 5V)$





Rise and fall times of OUT +8 are similar to those of OUT 1.



10KHz 100KHz 1 MHz 10MHZ 100MHz

OSCILLATOR FREQUENCY

ICM7209

0350-6

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ICM7209

# DETAILED DESCRIPTION

OSCILLATOR CONSIDERATIONS

The oscillator consists of a CMOS inverter with a non-linear resistor connected between the oscillator input and output to provide D.C. biasing. Using commercially obtainable quartz crystals the oscillator will operate from low frequencies (10kHz) to 10MHz.

The oscillator circuit consumes about 500µA of current using a 10MHz crystal with a 5 volt supply, and is designed to operate with a high impedance tank circuit. It is therefore necessary that the quartz crystal be specified with a load capacitance (C) of 10pF instead of the standard 30pF. To maximize the stability of the oscillator as a function of supply voltage and temperature, the motional capacitance of the crystal should be low (5mpF or less). Using a fixed input capacitor of 18pF and a variable capacitor of nominal value of 18pF on the output will result in oscillator stabilities of typically 1ppm per voit change in supply voltage.

#### THE ÷ 8 OUTPUT

A dynamic divider is used to divide the oscillator frequency by 8. Dynamic dividers use small nodal capacitances to

store voltage levels instead of latches (which are used in static dividers). The dynamic divider has advantages in high speed operation and low power but suffers from limited low frequency operation. This results in a window of operation for any oscillator frequency (see TYPICAL PERFORMANCE CHARACTERISTICS).

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#### OUTPUT DRIVERS

The output drivers consist of CMOS inverters having active pullups and pulldowns. Thus the outputs can be used to directly drive TTL gates, other CMOS gates operating with a 5 voit supply, or TTL compatible MOS gates. The guaranteed fanout is 5 TTL loads although typical fanout capability is at least 10 TTL loads with slightly increased output rise and fail times.

#### DEVICE POWER CONSUMPTION

At low frequencies the principal component of the power consumption is the oscillator. At high oscillator frequencies the major portion of the power is consumed by the output drivers, thus by disabling the outputs (activating the DIS-ABLE INPUT) the device power consumption can be dramatically reduced.

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